

## **DS1677 Portable System Controller**

20

19

ST

 $V_{\text{CC}}$ 

#### www.dalsemi.com

### **FEATURES**

- Provides Real Time Clock:
  - Counts seconds, minutes, hours, date of the month, month, day of the week, and year with leap year compensation valid up to 2100
  - Power control circuitry supports system power on from day/time alarm
- Microprocessor monitor:
  - Halts microprocessor during power-fail
  - Automatically restarts microprocessor after power failure
  - Monitors push-button for external override
  - Halts and resets an out of control microprocessor
- NV RAM control:
  - Automatic battery backup and write protection to external SRAM
- 3-channel, 8-bit analog-to-digital converter
- Simple 3-wire interface
- +5.0V operation
- 1.25V threshold detector for power-fail warning

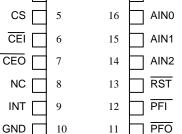
#### $V_{\text{cco}}$ SCLK X1 18 I/O X2 17 CS 5 16

PIN ASSIGNMENT

2

 $V_{BAT}$ 

GND



11

20-Pin TSSOP

10

#### ORDERING INFORMATION

DS1677E 20-Pin TSSOP

#### DESCRIPTION

The Portable System Controller is a circuit which incorporates many of the functions necessary for low power portable products integrated into one chip. The DS1677 provides a Real Time Clock, NV RAM controller, micro-processor monitor, power-fail warning, and a 3-channel, 8-bit analog-to-digital converter. Communication with the DS1677 is established through a simple 3-wire interface.

The Real Time Clock (RTC) provides seconds, minutes, hours, day, date, month, and year information with leap year compensation. The RTC also provides an alarm interrupt. This interrupt works when the DS1677 is powered by the system power supply or when in battery backup operation so the alarm can be used to wake up a system that is powered down.

> 1 of 17 050200

Automatic backup and write protection of an external SRAM is provided through the  $V_{CCO}$  and  $\overline{CE0}$  pins. The backup energy source used to power the RTC is also used to retain RAM data in the absence of  $V_{CC}$  through the  $V_{CCO}$  pin. The chip-enable output to SRAM,  $\overline{CE0}$ , is controlled during power transients to prevent data corruption.

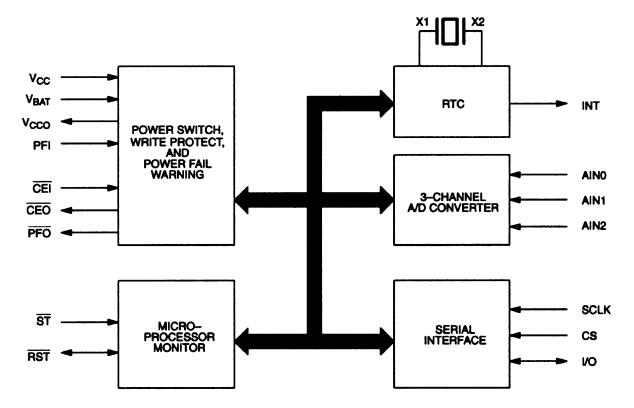
The microprocessor monitor circuitry of the DS1677 provides three basic functions. First, a precision temperature–compensated reference and comparator circuit monitors the status of  $V_{CC}$ . When an out–of–tolerance condition occurs, an internal power–fail signal is generated which forces the to  $\overline{\text{RST}}$  the active state. When  $V_{CC}$  returns to an in–tolerance condition, the  $\overline{\text{RST}}$  signal is kept in the active state for 250 ms to allow the power supply and processor to stabilize. The DS1677 debounces a push–button input and guarantees an active  $\overline{\text{RST}}$  pulse width of 250 ms. The third function is a watchdog timer. The DS1677 has an internal timer that forces the  $\overline{\text{RST}}$  signal to the active state if the strobe input is not driven low prior to watchdog time–out.

The DS1677 also provides a 3-channel 8-bit successive approximation analog-to-digital converter. The converter has an internal 2.55 volt (typical) reference voltage generated by an on-board band-gap circuit. The A/D converter is monotonic (no missing codes) and has an internal analog filter to reduce high frequency noise.

#### **OPERATION**

The block diagram in Figure 1 shows the main elements of the DS1677. The following paragraphs describe the function of each pin.

### **DS1677 BLOCK DIAGRAM Figure 1**



#### SIGNAL DESCRIPTIONS

 $V_{CC}$ , GND – DC power is provided to the device on these pins.  $V_{CC}$  is the +5.0 volt input.

**V**<sub>BAT</sub> (**Backup Power Supply**) – Battery input for standard 3 volt lithium cell or other energy source.

SCLK (Serial Clock Input) – SCLK is used to synchronize data movement on the serial interface.

I/O (Data Input/Output) – The I/O pin is the bi–directional data pin for the 3–wire interface.

**CS** (**Chip Select**) – The Chip Select signal must be asserted high during a read or a write for communication over the 3–wire serial interface.

 $V_{CCO}$  (External SRAM Power Supply Output) – This pin is internally connected to  $V_{CC}$  when  $V_{CC}$  is within nominal limits. However, during power–fail  $V_{CCO}$  is internally connected to the  $V_{BAT}$  pin. Switchover occurs when  $V_{CC}$  drops below  $V_{CCSW}$ .

**INT** (**Interrupt Output**) – The INT pin is an active high output of the DS1677 that can be used as an interrupt input to a microprocessor. The INT output remains high as long as the status bit causing the interrupt is present and the corresponding interrupt—enable bit is set. The INT pin operates when the DS1677 is powered by  $V_{CC}$  or  $V_{BAT}$ .

 $\overline{\text{CEI}}$  (SRAM Chip Enable In) –  $\overline{\text{CEI}}$  must be driven low to enable the external SRAM.

**CEO** (**SRAM Chip Enable Output**) – Chip enable output for SRAM.

**PFI** (**Power–Fail Input**) – Power–Fail comparator input. When PFI is less than 1.25V,  $\overline{PFO}$  goes low; otherwise  $\overline{PFO}$  remains high. Connect PFI to GND or  $V_{CC}$  when not used.

**PFO** (**Power–Fail Output**) – Power–Fail output goes low and sinks current when PFI is less than 1.25V; otherwise PFO remains high.

 $\overline{ST}$  (Strobe Input) – The Strobe input pin is used in conjunction with the watchdog timer. If the  $\overline{ST}$  pin is not driven low within the watchdog time period, the  $\overline{RST}$  pin is driven low.

 $\overline{\text{RST}}$  (Reset) – The  $\overline{\text{RST}}$  pin functions as a microprocessor reset signal. This pin is driven low 1) when  $V_{CC}$  is outside of nominal limits; 2) when the watchdog timer has "timed out"; 3) during the power–up reset period; and 4) in response to a push–button reset. The  $\overline{\text{RST}}$  pin also functions as a push–button reset input. When the  $\overline{\text{RST}}$  pin is driven low, the signal is debounced and timed such that a  $\overline{\text{RST}}$  signal of at least 250 ms is generated. This pin has an internal 47 k $\Omega$  pull up resistor.

**AIN0, AIN1, AIN2 (Analog Inputs)** – These pins are the three analog inputs for the 3–channel analog–to–digital converter.

**X1, X2** – Connections for a standard 32.768 kHz quartz crystal. For greatest accuracy, the DS1677 must be used with a crystal that has a specified load capacitance of 6 pF. There is no need for external capacitors or resistors. Note: X1 and X2 are very high impedance nodes. It is recommended that they and the crystal be guard–ringed with ground and that high frequency signals be kept away from the crystal area. For more information on crystal selection and crystal layout considerations, please consult Application Note 58, "Crystal Considerations with Dallas Real Time Clocks".

The DS1677 will not function without a crystal.

#### POWER-UP/POWER-DOWN CONSIDERATIONS

When  $V_{CC}$  is applied to the DS1677 and reaches a level greater than  $V_{CCTP}$  (power–fail trip point), the device becomes fully accessible after  $t_{RPU}$  (250 ms typical). Before  $t_{RPU}$  elapses, all inputs are disabled. When  $V_{CC}$  drops below  $V_{CCSW}$ , the device is switched over to the  $V_{BAT}$  supply.

During power–up, when  $V_{CC}$  returns to an in–tolerance condition, the  $\overline{RST}$  pin is kept in the active state for 250 ms (typical) to allow the power supply and microprocessor to stabilize.

### ADDRESS/COMMAND BYTE

The command byte for the DS1677 is shown in Figure 2. Each data transfer is initiated by a command byte. Bits 0 through 6 specify the address of the registers to be accessed. The MSB (bit 7) is the Read/Write bit. This bit specifies whether the accessed byte will be read or written. A read operation is selected if bit 7 is a zero and a write operation is selected if bit 7 is a one. The address map for the DS1677 is shown in Figure 3.

### **ADDRESS/COMMAND BYTE** Figure 2

7	6	5	4	3	2	1	0
$\overline{\text{RD}}$ WR	A6	A5	A4	A3	A2	A1	A0

### **DS1677 ADDRESS MAP** Figure 3

	BIT7					BIT0	
00	0	10	O SECO	NDS	SECONDS		
01	0	1	0 MINU	TES	MINUTES		
02	0	12	10 HR A/P	10 HR		HOURS	
03	0	0	0	0	0	DAY	
04	0	0	10 I	DATE		DATE	
05	0	0	0	10 MO.		MONTH	
06		10 \	YEAR			YEAR	
07	M	10	SEC AL	ARM	SECONDS ALARM		
08	M	10	MIN AL	ARM	MINUTES ALARM		
09	M	12	10 HR	10 HR	Н	IOUR ALARM	
0A	M	0	A/P 0	0	]	DAY ALARM	
0B			CONT	TROL REC			
0C			STA	TUS REG	ISTER		
0D			WATC	HDOG RE	EGIST	ER	
0E			ΑI	C REGIS	TER		
0F							
			]	RESERVE	ED		
7F							

## **CLOCK, CALENDAR AND ALARM**

The time and calendar information is accessed by reading/writing the appropriate register bytes. Note that some bits are set to zero. These bits will always read zero regardless of how they are written. Also note that registers 0Fh to 7Fh are reserved. These registers will always read zero regardless of how they are written. The contents of the time, calendar, and alarm registers are in the Binary–Coded Decimal (BCD) format.

The DS1677 can run in either 12-hour or 24-hour mode. Bit 6 of the hours register is defined as the 12-or 24-hour mode select bit. When high, the 12-hour mode is selected. In the 12-hour mode, bit 5 is the AM/PM bit with logic one being PM. In the 24-hour mode, bit 5 is the second 10-hour bit (20-23 hours).

The DS1677 also contains a time of day alarm. The alarm registers are located in registers 07h to 0Ah. Bit 7 of each of the alarm registers are mask bits (see Table 1). When all of the mask bits are logic 0, an alarm will occur once per week when the values stored in timekeeping registers 00h to 03h match the values stored in the time of day alarm registers. An alarm will be generated every day when mask bit of the day alarm register is set to one. An alarm will be generated every hour when the day and hour alarm mask bits are set to one. Similarly, an alarm will be generated every minute when the day, hour, and minute alarm mask bits are set to one. When day, hour, minute, and seconds alarm mask bits are set to one, an alarm will occur every second.

### TIME OF DAY ALARM BITS Table 1

ALARM R	REGISTER M	ASK BITS	(BIT 7)	
SECONDS	MINUTES	HOURS	DAYS	
1	1	1	1	Alarm once per second.
0	1	1	1	Alarm when seconds match.
0	0	1	1	Alarm when minutes and seconds match.
0	0	0	1	Alarm when hours, minutes and seconds match.
0	0	0	0	Alarm when day, hours, minutes and seconds match.

#### SPECIAL PURPOSE REGISTERS

The DS1677 has two additional registers (control register and status register) that control the Real Time Clock and interrupts.

### **CONTROL REGISTER**

BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
EOSC	WP	AIS1	AIS0	0	0	0	AIE

**EOSC** (Enable Oscillator) – This bit, when set to logic 0 will start the oscillator. When this bit is set to a logic 1, the oscillator is stopped and the DS1677 is placed into a low–power standby mode with a current drain of less than 200 nanoamps when in battery back–up mode. When the DS1677 is powered by  $V_{CC}$ , the oscillator is always on regardless of the status of the  $\overline{EOSC}$  bit; however, the real time clock is incremented only when  $\overline{EOSC}$  is a logic 0.

**WP** (Write Protect) – Before any write operation to the real time clock or any other registers, this bit must be logic 0. When high, the write protect bit prevents a write operation to any register.

**AIS0–AIS1 (Analog Input Select)** – These 2 bits are used to determine the analog input for the analog–to–digital conversion. Table 2 lists the specific analog input that is selected by these 2 bits.

**AIE (Alarm Interrupt Enable)** – When set to a logic 1, this bit permits the Interrupt Request Flag (IRQF) bit in the status register to assert INT. When the AIE bit is set to logic 0, the IRQF bit does not initiate the INT signal.

#### **ANALOG INPUT SELECTION** Table 2

AIS1	AIS0	ANALOG INPUT
0	0	NONE
0	1	AIN0
1	0	AIN1
1	1	AIN2

### STATUS REGISTER

BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
CU	LOBAT	0	0	0	0	0	IRQF

CU (Conversion Update In Progress) – When this bit is a one, an update to the ADC Register (register 0Eh) will occur within 488  $\mu$ s. When this bit is a zero, an update to the ADC Register will not occur for at least 244  $\mu$ s.

**LOBAT (Low Battery Flag)** – This bit reflects the status of the backup power source connected to the  $V_{PAT}$  pin. When  $V_{PAT}$  is greater than 2.5 volts, LOBAT is set to a logic 0. When  $V_{PAT}$  is less than 2.3 volts, LOBAT is set to a logic 1.

**IRQF (Interrupt Request Flag)** – A logic 1 in the Interrupt Request Flag bit indicates that the current time has matched the time of day Alarm registers. If the AIE bit is also a logic 1, the INT pin will go high. IRQF is cleared by reading or writing to any of the alarm registers.

#### NONVOLATILE SRAM CONTROLLER

The DS1677 provides automatic backup and write protection for an external SRAM. This function is pro-vided by gating the chip enable signal and by providing a constant power supply through the  $V_{\rm CCO}$  pin.

The DS1677 nonvolatizes the external SRAM by write protecting the SRAM and by providing a back–up power supply in the absence of  $V_{CC}$ . When  $V_{CC}$  falls below  $V_{PF}$ , access to the external SRAM is prohibited by forcing  $\overline{\text{CE0}}$  high regardless of the level of  $\overline{\text{CEI}}$ . Upon power–up, access is prohibited until the end of  $t_{RPU}$ .

#### POWER-FAIL COMPARATOR

The PFI input is connected to an internal reference. If PFI is less than 1.25V,  $\overline{PFO}$  goes low. The power-fail comparator can be used as an undervoltage detector to signal an impending power supply failure.  $\overline{PFO}$  can be used as a  $\mu P$  interrupt input to prepare for power-down. For battery conservation, the comparator is turned off and  $\overline{PFO}$  is held low when in battery-backed mode

#### ADDING HYSTERESIS TO THE POWER-FAIL COMPARATOR

Hysteresis adds a noise margin to the power–fail comparator and prevents  $\overline{PFO}$  from oscillating when VIN is near the power–fail comparator trip point. Figure 8 shows how to add hysteresis to the power–fail comparator. Select the ratio of R1 and R2 such that PFI sees 1.25 volt when VIN falls to the desired trip point (VTRIP). Resistors R2 and R3 adds hysteresis. R3 will typically be an order of magnitude greater than R1 or R2. R3 should be chosen in manner to prevent it from loading down the  $\overline{PFO}$  pin. Capacitor C1 adds noise filtering and has a value of typically 1.0 uF. See Figure 8 for a schematic diagram and equations.

#### MICROPROCESSOR MONITOR

The DS1677 monitors three vital conditions for a micro-processor: power supply, software execution, and external override.

First, a precision temperature–compensated reference and comparator circuit monitors the status of  $V_{CC}$ . When an out–of–tolerance condition occurs, an internal power–fail signal is generated which forces the  $\overline{\text{RST}}$  pin to the active state thus warning a processor–based system of impending power failure. When  $V_{CC}$  returns to an in–tolerance condition upon power–up, the reset signal is kept in the active state for 250 ms (typical) to allow the power supply and microprocessor to stabilize. Note however that if the  $\overline{\text{EOSC}}$  bit is set to a logic 1 (to disable the oscillator during battery back–up mode), the  $\overline{\text{RST}}$  signal will be kept in an active state for 250 ms plus the start–up time of the oscillator.

The second monitoring function is push-button reset control. The DS1677 provides for a push-button switch to be connected to the  $\overline{\text{RST}}$  output pin. When the DS1677 is not in a reset cycle, it continuously monitors the  $\overline{\text{RST}}$  signal for a low going edge. If an edge is detected, the DS1677 will debounce the switch by pulling the  $\overline{\text{RST}}$  line low. After the internal 250 ms timer has expired, the DS1677 will continue to monitor the  $\overline{\text{RST}}$  line. If the line is still low, the DS1677 will continue to monitor the line looking for a rising edge. Upon detecting release, the DS1677 will force the  $\overline{\text{RST}}$  line low and hold it low for 250 ms.

The third microprocessor monitoring function provided by the DS1677 is a watchdog timer. The watchdog timer function forces  $\overline{RST}$  to the active state when the  $\overline{ST}$  input is not stimulated within the predetermined time period. The time period is set by the Time Delay (TD) bits in the Watchdog Register. The time delay can be set to 250 ms, 500 ms, or 1000 ms (see Figure 4). If TD0 and TD1 are both set to zero, the watchdog timer is disabled. When enabled, the watchdog timer starts timing out from the set time period as soon as  $\overline{RST}$  is inactive. The default setting is for the watchdog timer to be enabled with 1000 ms time delay. If a high–to–low transition occurs on the  $\overline{ST}$  input pin prior to time–out, the watchdog timer is reset and begins to time–out again. If the watchdog timer is allowed to time–out, then the  $\overline{RST}$  signal is driven to the active state for 250 ms (typical). The  $\overline{ST}$  input can be derived from microprocessor address signals, data signals, and/or control signals. To guarantee that the watchdog timer does not time–out, a high–to–low transition must occur at or less than the minimum period.

## WATCHDOG TIME-OUT CONTROL Figure 4

#### WATCHDOG REGISTER

BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0
0	0	0	0	0	0	TD1	TD0

#### WATCHDOG REGISTER

TD1	TD0	WATCHDOG TIME-OUT
0	0	WATCHDOG DISABLED
0	1	250 ms
1	0	500 ms
1	1	1000 ms

#### ANALOG-TO-DIGITAL CONVERTER

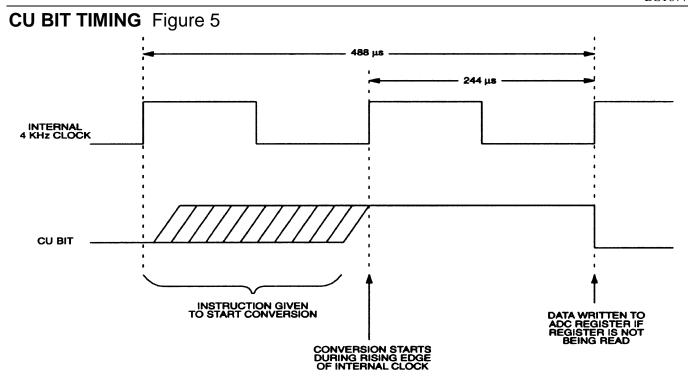
The DS1677 provides a 3-channel 8-bit analog-to-digital converter. The A/D reference voltage (2.55 volt typical) is derived from an on-chip band-gap circuit. Three multiplexed analog inputs are provided through the AIN0, AIN1, and AIN2 pins. The A/D converter is monotonic (no missing codes) and uses a successive approximation technique to convert the analog signal into a digital code.

An A/D conversion is the process of assigning a digital code to an analog input voltage. This code represents the input value as a fraction of the full scale voltage (FSV) range. Thus the FSV range is then divided by the A/D converter into 256 codes (8 bits). The FSV range is bounded by an upper limit equal to the reference voltage and the lower limit which is ground. The DS1677 has a FSV of 2.55 volt (typical) which provides a resolution of 10 mV. An input voltage equal to the reference voltage converts to FFh while an input voltage equal to ground converts to 00h. The relative linearity of the A/D converter is  $\pm 0.5 \text{ LSB}$ .

The A/D converter selects from one of three different analog inputs (AIN0 – AIN2). The input that is selected is determined by the Analog Input Select (AIS) bits in the Control Register. Table 2 lists the specific analog input that is selected by these 2 bits. Note also that the converter can be turned off by these bits to reduce power. When the A/D is turned on by setting AIS0 and AIS1 to any value other than 0,0 the analog input voltage is converted and written to the ADC Register within 488 μs. An internal analog filter at the input reduces high frequency noise. Subsequent updates occur approximately every 10 ms. If AIS0 and/or AIS1 are changed, updates will occur at the next 10 ms conversion time.

The Conversion Update In Progress (CU) bit in the Status Register indicates when the ADC Register can be read. When this bit is a one, an update to the ADC Register will occur within 488  $\mu$ s maximum. However, when this bit is zero an update will not occur for at least 244  $\mu$ s. The CU bit should be polled before reading the ADC Register to insure that the contents are stable during a read cycle. Once a read cycle to the ADC Register has been started, the DS1677 will not update that register until the read cycle has been completed. It should also be mentioned that taking CS low will abort the read cycle and will allow the ADC Register to be updated.

Figure 5 illustrates the timing of the CU bit relative to an instruction to begin conversion and the completion of that conversion.



#### 3-WIRE SERIAL INTERFACE

Communication with the DS1677 is accomplished through a simple 3-wire interface consisting of the Chip Select (CS), Serial Clock (SCLK) and Input/Output (I/O) pins.

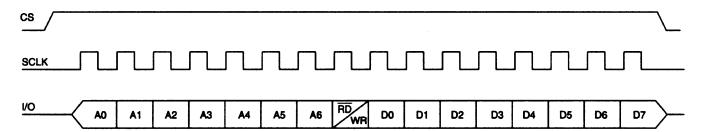
All data transfers are initiated by driving the CS input high. The CS input serves two functions. First, CS turns on the control logic which allows access to the shift register for the address/command sequence. Second, the CS signal provides a method of terminating either single byte or multiple byte (burst) data transfer. A clock cycle is a sequence of a rising edge followed by a falling edge. For data input, data must be valid during the rising edge of the clock and data bits are output on the falling edge of the clock. If the CS input goes low, all data transfer terminates and the I/O pin goes to a high impedance state.

Address and data bytes are always shifted LSB first into the I/O pin. Any transaction requires the address/command byte to specify a read or write to a specific register followed by one or more bytes of data. The address byte is always the first byte entered after CS is driven high. The most significant bit (RD/WR) of this byte determines if a read or write will take place. If this bit is 0, one or more read cycles will occur. If this bit is 1, one or more write cycles will occur.

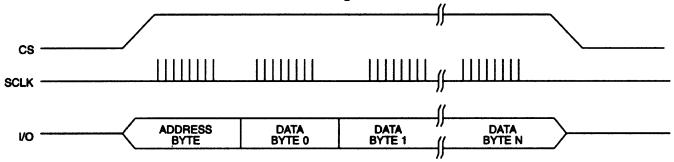
Data transfers can occur one byte at a time or in multiple byte burst mode. After CS is driven high an address is written to the DS1677. After the address, one or more data bytes can be read or written. For a single byte transfer one byte is read or written and then CS is driven low. For a multiple byte transfer, multiple bytes can be read or written to the DS1677 after the address has been written. Each read or write cycle causes the register address to automatically increment. Incrementing continues until the device is disabled. After accessing register 0Eh, the address wraps to 00h.

Data transfer for single byte transfer and multiple byte burst transfer is illustrated in Figures 6 and 7.

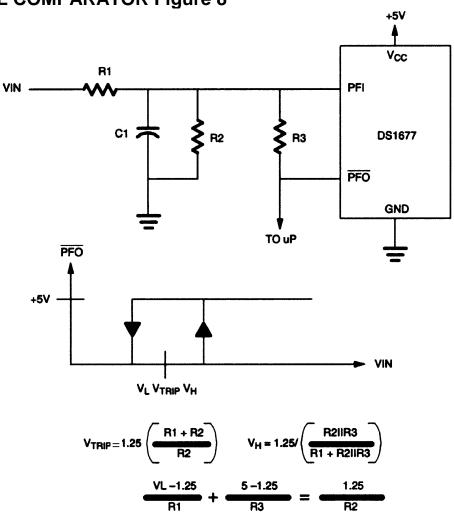
## **SINGLE BYTE DATA TRANSFER** Figure 6



## **MULTIPLE BYTE BURST TRANSFER** Figure 7



## **POWER-FAIL COMPARATOR Figure 8**



### **ABSOLUTE MAXIMUM RATINGS\***

Voltage on Any Pin Relative to Ground

Operating Temperature

Storage Temperature

O°C to 70°C

-55°C to +125°C

Soldering Temperature

See J-STD-020A

#### RECOMMENDED DC OPERATING CONDITIONS

(0°C to 70°C)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Power Supply Voltage	$V_{CC}$	4.5	5.0	5.5	V	1
5V Operation						
Input Logic 1	$V_{IH}$	2.0		V <sub>CC</sub> +0.3	V	1
Input Logic 0	$V_{ m IL}$	-0.3		+0.8	V	1
Battery Voltage	$V_{\mathrm{BAT}}$	2.5		3.7	V	1

### DC ELECTRICAL CHARACTERISTICS

 $(0^{\circ}\text{C to } 70^{\circ}\text{C}; V_{\text{CC}}=5.0\text{V}\pm10\%)$ 

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Input Leakage	$I_{LI}$	-1		+1	μΑ	
CS Leakage	$I_{LO}$			150	μΑ	7
Logic 1 Output	V <sub>OH</sub>	2.4			V	2
Logic 0 Output	$V_{OL}$			0.4	V	3
Active Supply Current (CS=V <sub>CC</sub> -0.2)	$I_{CCA}$		1.5	2.0	mA	4
A/D Converter Current	$I_{ADC}$			500	μΑ	5
Standby Current (CS=V <sub>IL</sub> )	$I_{CCS}$			300	μΑ	6
Oscillator Current	I <sub>OSC</sub>		300	500	nA	
Battery Standby Current (Oscillator Off)	$I_{BAT}$			200	nA	
Internal RST Pull-Up Resistor	$R_{P}$	35	47	60	kΩ	
V <sub>CC</sub> Trip Point	$V_{CCTP}$	4.25	4.35	4.50	V	
V <sub>CC</sub> Switchover	$V_{CCSW}$	2.60	2.70	2.80	V	12
A/D Reference Voltage	$V_{ADC}$	2.47	2.55	2.63	V	
Pushbutton Detect	$PB_{DV}$	0.8		2.0	V	
Pushbutton Release	$PB_{RD}$		0.3	0.8	V	
Output Voltage	$V_{CCO}$	$V_{CC}$ -0.3			V	11
PFI Input Threshold	$V_{ m PFI}$	1.20	1.25	1.30	V	
PFI Input Current	$I_{\mathrm{PFI}}$	0.25	0.01	25	nA	
$\overline{PFO}$ Output voltage $I_{OH} = -1 \mu A$	$V_{OH}$	V <sub>CC</sub> -1.5			V	
$\overline{\text{PFO}}$ Output voltage $I_{OL} = 3.2 \mu\text{A}$	V <sub>OL</sub>			0.4	V	
V <sub>CCO</sub> Output Current (Source=V <sub>CC</sub> )	$I_{CCO1}$			150	mA	13
V <sub>CCO</sub> Output Current (Source=V <sub>BAT)</sub>	I <sub>CCO2</sub>			150	μΑ	14

<sup>\*</sup> This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods of time may affect reliability.

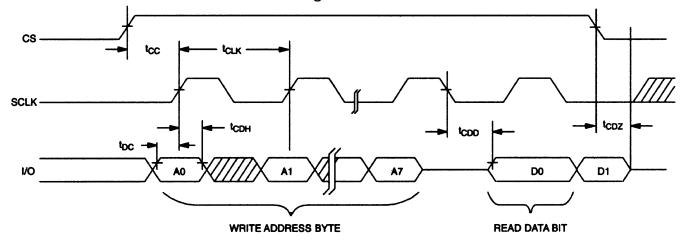
**CAPACITANCE**  $(t_A=25^{\circ}C)$ 

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Input Capacitance	$C_{I}$		10		pF	
I/O Capacitance	C <sub>I/O</sub>		15		pF	
Crystal Capacitance	$C_X$		6		pF	

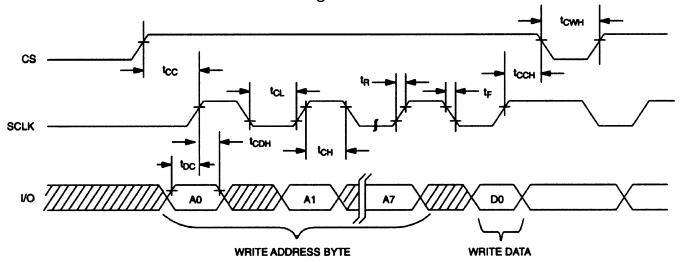
**AC ELECTRICAL CHARACTERISTICS** (0°C to 70°C;  $V_{CC}$ =5.0V±10%)

AC ELECTRICAL CHARACTE		$(0^{\circ}C \ 10^{\circ}C, V_{CC}=5.0V\pm10\%)$				
PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
Data to Clock Setup	$t_{\rm DC}$	50			ns	8
CLK to Data Hold	t <sub>CDH</sub>	70			ns	8
CLK to Data Delay	t <sub>CDD</sub>			200	ns	8, 9, 10
CLK to Low Time	$t_{ m CL}$	250			ns	8
CLK to High Time	$t_{CH}$	250			ns	8
CLK Frequency	$t_{CLK}$			2.0	MHz	8
CLK Rise and Fall	$t_{\rm R},t_{\rm F}$			500	ns	
CS to CLK Setup	$t_{CC}$	1			μs	8
CLK to CS Hold	t <sub>CCH</sub>	60			ns	8
CS Inactive Time	$t_{CWH}$	1			μs	8
CS to I/O High-Z	$t_{CDZ}$			70	ns	8
V <sub>CC</sub> Slew Rate (4.5V to 2.3V)	$t_{\mathrm{F}}$	1			ms	
V <sub>CC</sub> Slew Rate (2.3V to 4.5V)	$t_R$	0			ns	
V <sub>CC</sub> Detect to RST (V <sub>CC</sub> Falling)	$t_{ m RPD}$			100	ns	
Reset Active Time	$t_{RST}$		250		ms	15
Pushbutton Debounce	$PB_{DB}$		250		ms	15
V <sub>CC</sub> Detect to RST (V <sub>CC</sub> Rising)	$t_{ m RPU}$		250		ms	15, 16
ST Pulse Width	$t_{ m ST}$	20			ns	
Chip Enable Propagation Delay to External SRAM	t <sub>CED</sub>		8	15	ns	
Nominal Voltage to V <sub>CC</sub> Switchover Fall Time	t <sub>FB</sub>	200			μs	
PFI Low to PFO Low	t <sub>PFD</sub>		2		μs	
PFI High to PFO High	$t_{ m PFU}$		2		μs	

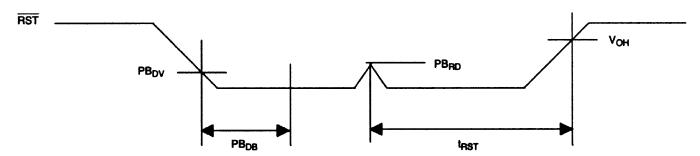
# TIMING DIAGRAM: READ DATA Figure 9



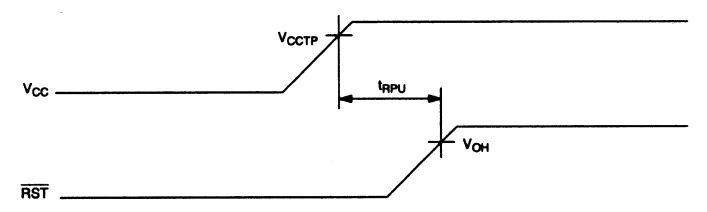
## TIMING DIAGRAM: WRITE DATA Figure 10

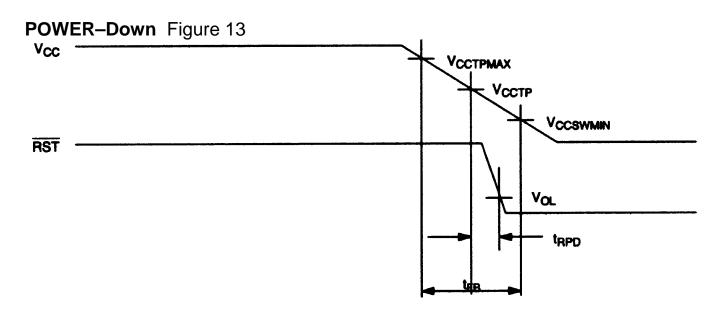


## **PUSH-BUTTON RESET** Figure 11

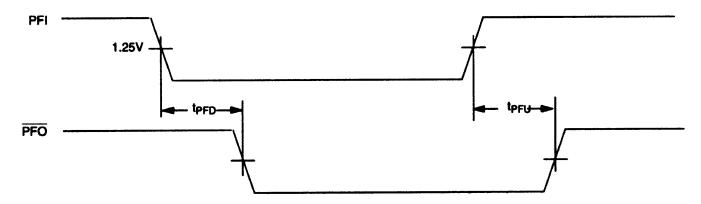


# POWER-UP Figure 12



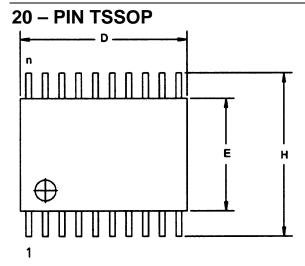


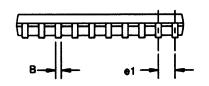
### **POWER-FAIL WARNING** Figure 14

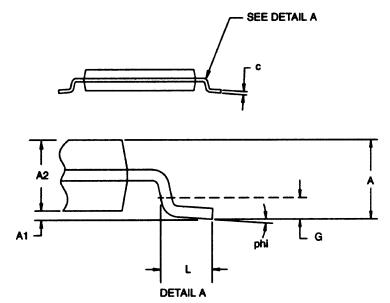


#### **NOTES:**

- 1. All voltages are referenced to ground.
- 2. Logic one voltages are specified at a source current of 0.4 mA at  $V_{CC}$ =3.0V,  $V_{OH}$ = $V_{CC}$  for capacitive loads.
- 3. Logic zero voltages are specified at a sink current of 1.5 mA at V<sub>CC</sub>=3.0, V<sub>OL</sub>=GND for capacitive loads.
- 4. I<sub>CCA</sub> is specified with outputs open, CS set to a logic 1, SCLK=500 kHz, oscillator enabled, and A/D converter enabled.
- 5. I<sub>ADC</sub> is specified with CS, V<sub>CCO</sub> open and I/O, SCLK at logic zero. A/D converter is enabled.
- 6. I<sub>CCS</sub> is specified with CS, V<sub>CCO</sub> open and I/O, SCLK at logic zero. A/D converter is disabled.
- 7. CS has a 40 k $\Omega$  pull-down resistor to ground.
- 8. Measured at  $V_{IH} = 2.0 \text{V}$  or  $V_{IL} = 0.8 \text{V}$  and 10 ns maximum rise and fall time.
- 9. Measured at  $V_{OH} = 2.4 \text{V}$  or  $V_{OL} = 0.4 \text{V}$ .
- 10. Load capacitance= 25 pF.
- 11.  $I_{CCO}=100 \text{ mA}, V_{CC} > V_{CCTP}$ .
- 12.  $V_{CCO}$  switchover from  $V_{CC}$  to  $V_{BAT}$  occurs when  $V_{CC}$  drops below the lower of  $V_{CCSW}$  and  $V_{BAT}$ .
- 13. Current from  $V_{CC}$  input pin to  $V_{CCO}$  output pin.
- 14. Current from  $V_{BAT}$  input pin to  $V_{CCO}$  output pin.
- 15. Timebase is generated by very accurate crystal oscillator. Accuracy of this time period is based on the crystal that is used. A typical crystal with a specified load capacitance of 6 pF will provide an ccuracy within ±100 ppm over the 0°C to 70°C temperature range. For greater accuracy see DS32KHz data sheet.
- 16. If the EOSC bit in the Control Register is set to a logic 1, t<sub>RPU</sub> is equal to 250 ms plus the start–up time of the crystal oscillator.







PKG	20-PIN		
DIM	MIN		MAX
A MM	-		1.10
A1 MM	0.05		-
A2 MM	0.75		1.05
CMM	0.09		0.18
LMM	0.	.50	0.70
e1 MM	0.65 BSC		
BMM	0.18		0.30
D MM	6.40		6.90
EMM	4.40 NOM.		
G MM	0.25 REF.		
H MM	6.25		6.55
phi	0°	8°	